IRMTOUCH INC.

IR Multi-Point TOUCH FRAME

Model: TII70-XX-N Serial Model: See P5

November 12, 2013 Report No.: 13020703-FCC-E

(This report supersedes NONE)



Modifications made to the product: None

| This Test Report is Issued Under the Authority of: | | | | |
|--|--------------------------|--|--|--|
| Jason Warg | Alex. Lin | | | |
| Jason Wang | Alex Liu | | | |
| Compliance Engineer | Technical Manager | | | |

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Accreditations for Conformity Assessment

| reductions for comorning assessment | | | | | | |
|-------------------------------------|------------------------|-----------------------------------|--|--|--|--|
| Country/Region | Accreditation Body | Scope | | | | |
| USA | FCC, A2LA | EMC, RF/Wireless, Telecom | | | | |
| Canada | IC, A2LA, NIST | EMC, RF/Wireless, Telecom | | | | |
| Taiwan | BSMI, NCC , NIST | EMC, RF, Telecom, Safety | | | | |
| Hong Kong | OFTA, NIST | RF/Wireless,Telecom | | | | |
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| Korea | KCC/RRA, NIST | EMI, EMS, RF, Telecom, Safety | | | | |
| Japan | VCCI, JATE, TELEC, RFT | EMI, RF/Wireless, Telecom | | | | |
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Accreditations for Product Certifications

| Country/Region | Accreditation Body | Scope |
|----------------|--------------------|-----------------------|
| USA | FCC TCB, NIST | EMC, RF, Telecom |
| Canada | IC FCB, NIST | EMC, RF, Telecom |
| Singapore | iDA, NIST | EMC, RF, Telecom |
| EU | NB | EMC & R&TTE Directive |
| Japan | MIC, (RCB 208) | RF, Telecom |
| Hong Kong | OFTA (US002) | RF, Telecom |



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ENIC Test Report for IR Multi-Point TOUCH FRAME
TII70-XX-N
I Model See P5
FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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1 EXECUTIVE SUMMARY & EUT INFORMATION

The purpose of this test programme was to demonstrate compliance of the IRMTOUCH INC., IR Multi-Point TOUCH FRAME and Model: TII70-XX-N against the current Stipulated Standards. The IR Multi-Point TOUCH FRAME has demonstrated compliance with the FCC Part 15 Subpart B Class B: 2013.

EUT Information

EUT

Description

: IR Multi-Point TOUCH FRAME

Model : TII70-XX-N

Serial Model TH65-XX-N, TH60-XX-N, TH55-XX-N, TH52-XX-N TH47-XX-N,

TII46-XX-N, TII42-XX-N, TII37-XX-N, TII32-XX-N

Input Power : DC 5V By USB Power Supply

Classification

Class B Emission Product Per

Per Stipulated
Test Standard

FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009



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2 TECHNICAL DETAILS

| _ | |
|--|---|
| Purpose | Compliance testing of IR Multi-Point TOUCH FRAME with stipulated standards |
| Applicant / Client | IRMTOUCH INC. Building 5,No 445 Humin Road,Minhang,Shanghai,China |
| Manufacturer | IRMTOUCH INC. Building 5,No 445 Humin Road,Minhang,Shanghai,China |
| Laboratory performing the tests | SIEMIC (Nanjing-China) Laboratories NO.2-1,Longcang Dadao, Yuhua Economic Development Zone, Nanjing, China Tel: +86(25)86730128/86730129 Fax: +86(25)86730127 Email: China@siemic.com.cn |
| Test report reference number | 13020703-FCC-E |
| Date EUT received | 7th August, 2013 |
| Standard applied | FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009 |
| Dates of test (from – to) | 27th August to 28th August, 2013 |
| No of Units | #1 |
| Equipment Category | Class B Emission Product |
| Trade Name | IRMT |
| Highest Operated Frequency(ies) | 8MHz |
| Port/Connectors | USB Port |
| FCC ID | 2AASUIRMTTII |



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MODIFICATION

NONE



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4 TEST SUMMARY

The product was tested in accordance with the following specifications. All testing has been performed according to below product classification:

Class B Emission Product

Test Results Summary

| Emissions | | | | | |
|---|---------------------|------------------|-------------|--|--|
| Test Standard | Description | Product Class | Pass / Fail | | |
| FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009 | Conducted Emissions | See Above | Pass | | |
| FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009 | Radiated Emissions | See Above | Pass | | |

All measurement uncertainty is not taken into consideration for all presented test result.



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5 <u>MEASUREMENTS, EXAMINATION AND DERIVED</u> RESULTS

5.1 Conducted Emissions Test Results

Note:

- 1. All possible modes of operation were investigated. Only the several worst case emissions measured, using the correct CISPR and Average detectors, are reported. All other emissions were relatively insignificant.
- 2. A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.
- 3. <u>Conducted Emissions Measurement Uncertainty</u>

All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 9kHz - 30MHz (Average & Quasi-peak) is $\pm 3.86dB$.

4. Environmental Conditions Temperature 25°C Relative Humidity 65%

Atmospheric Pressure 995mbar

5. Test Date: 27th August, 2013 Tested By: Jason Wang

Test Result: Pass

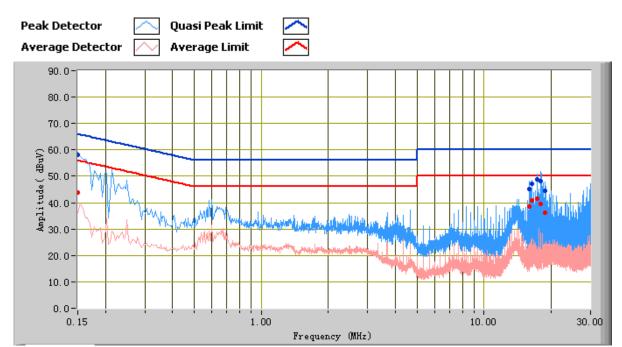
To:

See P5 FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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Test Data

Phase Line Plot at 120Vac, 60Hz

| = = = | | | | | | | |
|-----------------|-------------------------|-----------------|-------------|-------------------|-----------------|-------------|--------------|
| Frequency (MHz) | Quasi Peak (dBµV) | Limit (dBµV) | Margin (dB) | Average (dBµV) | Limit (dBµV) | Margin (dB) | Factors (dB) |
| 0.15 | 58.22 | 66.00 | -7.78 | 43.72 | 56.00 | -12.28 | 12.22 |
| 18.00 | 48.02 | 60.00 | -11.98 | 39.50 | 50.00 | -10.50 | 11.49 |
| 17.33 | 48.67 | 60.00 | -11.33 | 41.56 | 50.00 | -8.44 | 11.47 |
| 16.33 | 47.07 | 60.00 | -12.93 | 40.87 | 50.00 | -9.13 | 11.45 |
| 16.00 | 45.12 | 60.00 | -14.88 | 38.56 | 50.00 | -11.44 | 11.44 |
| 18.66 | 44.63 | 60.00 | -15.37 | 36.27 | 50.00 | -13.73 | 11.51 |

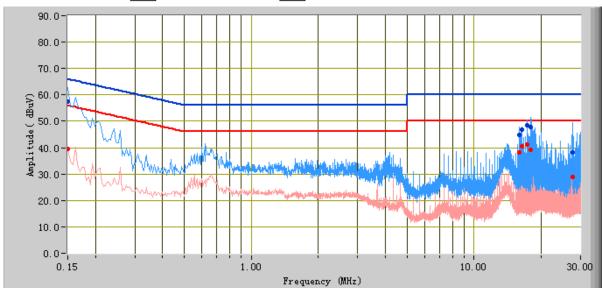
See P5 FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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Normal Working **Test Mode:**





Test Data

Phase Neutral Plot at 120Vac, 60Hz

| Frequency (MHz) | Quasi Peak (dBµV) | Limit (dBµV) | Margin (dB) | Average (dBµV) | Limit (dBµV) | Margin (dB) | Factors (dB) |
|-----------------|-------------------------|-----------------|-------------|-------------------|-----------------|-------------|--------------|
| 0.15 | 57.43 | 66.00 | -8.57 | 39.67 | 56.00 | -16.33 | 12.21 |
| 18.00 | 47.67 | 60.00 | -12.33 | 39.24 | 50.00 | -10.76 | 11.50 |
| 17.33 | 48.44 | 60.00 | -11.56 | 41.24 | 50.00 | -8.76 | 11.48 |
| 27.66 | 38.03 | 60.00 | -21.97 | 28.76 | 50.00 | -21.24 | 11.82 |
| 16.33 | 46.67 | 60.00 | -13.33 | 40.48 | 50.00 | -9.52 | 11.44 |
| 16.00 | 44.86 | 60.00 | -15.14 | 38.20 | 50.00 | -11.80 | 11.43 |

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5.2 Radiated Emissions Test Results

Note:

1. All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR detectors, are reported. All other emissions were relatively insignificant.

2. A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.

3. <u>Radiated Emissions Measurement Uncertainty</u>

All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 30 MHz - 1 GHz (QP only @ 3m & 10m) is +6 dB/-6 dB (for EUTs < 0.5 m X 0.5 m).

4. Environmental Conditions Temperature 25°C Relative Humidity 60%

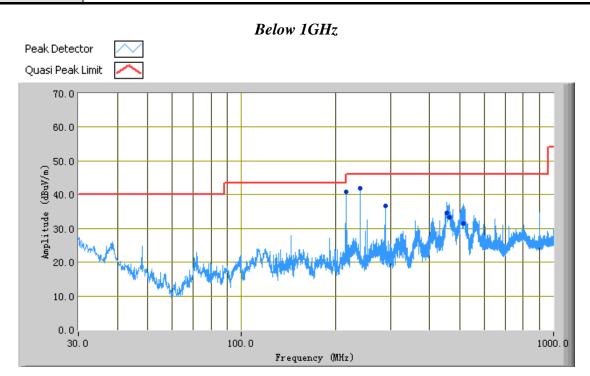
Atmospheric Pressure 998mbar

5. Test Date: 28th August, 2013 Tested By: Jason Wang

Test Result: Pass

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Test Mode: Normal Working



Test Data

Vertical& Horizontal Polarity Plot at 3m

| Frequency (MHz) | Peak (dBµV/m) | Azimuth | Polarity (H/V) | Height (cm) | Factors (dB) | Limit (dBµV/m) | Margin (dB) |
|-----------------|------------------|---------|-------------------|-------------|--------------|-------------------|----------------|
| 239.99 | 41.87 | 338.00 | Н | 146.00 | -32.40 | 46.00 | -4.13 |
| 216.42 | 40.96 | 132.00 | Н | 153.00 | -33.35 | 46.00 | -5.04 |
| 454.45 | 34.62 | 242.00 | V | 110.00 | -29.13 | 46.00 | -11.38 |
| 463.96 | 33.22 | 241.00 | V | 101.00 | -29.03 | 46.00 | -12.78 |
| 514.16 | 31.53 | 18.00 | Н | 253.00 | -28.45 | 46.00 | -14.47 |
| 239.99 | 41.87 | 338.00 | Н | 146.00 | -32.40 | 46.00 | -4.13 |

Note: the highest frequency of the internal sources of the EUT is less than 108MHz, so the measurement shall only be made up to 1GHz.

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Annex A. TEST INSTRUMENTATION & METHOD

Annex A.i. TEST INSTRUMENTATION & GENERAL PROCEDURES

| Instrument | Model | Serial # | Calibration Date | Calibration Due Date |
|--|--------------------------------|--------------------|---------------------|-------------------------|
| AC Line Conducted Emissions | | | | |
| R&S EMI Test Receiver | ESPI3 | 101216 | 09/27/2012 | 09/26/2013 |
| ROHDE&SCHWARZ V-LISN | ESH3-Z5 | 838979/005 | 09/27/2012 | 09/26/2013 |
| Com-Power Transient Limiter | LIT-153 | 531021 | 09/27/2012 | 09/26/2013 |
| SIEMIC Labview Conducted Emissions software | V1.0 | N/A | N/A | N/A |
| Radiated Emissions | | | | |
| Hp Spectrum Analyzer | 8563E | 3821A09023 | 09/27/2012 | 09/26/2013 |
| R&S EMI Receiver | ESPI3 | 101216 | 09/27/2012 | 09/26/2013 |
| Antenna (30MHz~6GHz) | JB6 | A121411 | 03/27/2013 | 03/26/2014 |
| ETS-Lindgren Antenna (1 ~18GHz) | 3115 | N/A | 10/27/2012 | 10/26/2013 |
| A-INFOMW Antenna (1 ~18GHz) | JXTXLB- 10180 | J2031081120 092 | 10/09/2012 | 10/08/2013 |
| Horn Antenna (18~40GHz) | AH-840 | 101013 | 09/27/2012 | 09/26/2013 |
| Microwave Pre-Amp (18~40GHz) | PA-840 | 181250 | 09/27/2012 | 09/26/2013 |
| Hp Agilent Pre-Amplifier | 8447F | 1937A01160 | 10/27/2012 | 10/26/2013 |
| MITEQ Pre-Amplifier (0.1 ~ 18GHz) | AMF-7D- 00101800- 30-10P | 1451709 | 10/27/2012 | 10/26/2013 |
| Chamber | 3m | N/A | 04/13/2013 | 04/12/2014 |
| SIEMIC Labview Radiated Emissions software | V1.0 | N/A | N/A | N/A |

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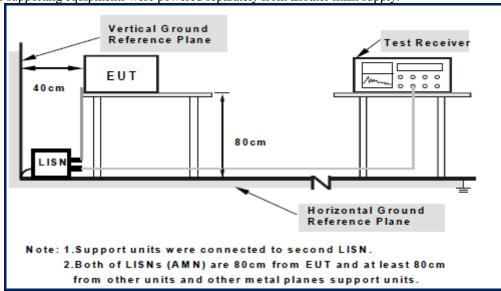
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Annex A.ii. CONDUCTED EMISSIONS TEST DESCRIPTION

Test Set-up

- 1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m x 1m x 0.8m high, non-metallic table, as shown in Annex B.
- 2. The power supply for the EUT was fed through a $50\Omega/50\mu$ H EUT LISN, connected to filtered mains.
- 3. The RF OUT of the EUT LISN was connected to the EMI test receiver via a low-loss coaxial cable.

4. All other supporting equipments were powered separately from another main supply.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration1

Test Method

- 1. The EUT was switched on and allowed to warm up to its normal operating condition.
- 2. A scan was made on the NEUTRAL line (for AC mains) or Earth line (for DC power) over the required frequency range using an EMI test receiver.
- 3. High peaks, relative to the limit line, were then selected.
- 4. The EMI test receiver was then tuned to the selected frequencies and the necessary measurements made with a receiver bandwidth setting of 10kHz. For FCC tests, only Quasi-peak measurements were made; while for CISPR/EN tests, both Quasi-peak and Average measurements were made.
- 5. Steps 2 to 4 were then repeated for the LIVE line (for AC mains) or DC line (for DC power).

Sample Calculation Example

At 20MHz $limit = 250\mu V = 47.96dB\mu V$

Transducer factor of LISN, pulse limiter & cable loss at 20MHz = 11.20dB

Q-P reading obtained directly from EMI Receiver = 40.00dB μ V

(Calibrated for system losses)

Therefore, Q-P margin = 40.00-47.96 = -7.96 i.e. **7.96 dB below limit**

Annex A.iii. RADIATED EMISSIONS TEST DESCRIPTION

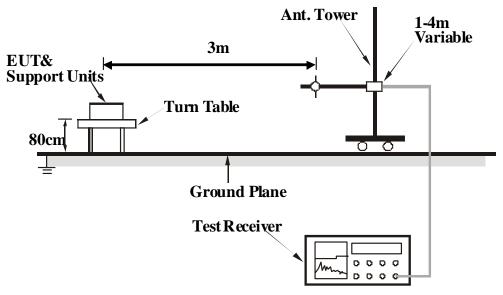
EUT Characterisation

EUT characterisation, over the frequency range from 30MHz to 10th Harmonic, was done in order to minimise radiated emissions testing time while still maintaining high confidence in the test results.

The EUT was placed in the chamber, at a height of about 0.8 m on a turntable. Its radiated emissions frequency profile was observed, using a spectrum analyzer /receiver with the appropriate broadband antenna placed 3m away from the EUT. Radiated emissions from the EUT were maximised by rotating the turntable manually, changing the antenna polarisation and manipulating the EUT cables while observing the frequency profile on the spectrum analyzer / receiver. Frequency points at which maximum emissions occurred; clock frequencies and operating frequencies were then noted for the formal radiated emissions test at the Open Area Test Site (OATS) or 3m EMC chamber.

Test Set-up

- 1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5mX1.0mX0.8m high, non-metallic table.
- 2. The filtered power supply for the EUT and supporting equipment were tapped from the appropriate power sockets located on the turntable.
- 3. The relevant broadband antenna was set at the required test distance away from the EUT and supporting equipment boundary.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration2

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Test Method

The following procedure was performed to determine the maximum emission axis of EUT:

- 1. With the receiving antenna is H polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
- 2. With the receiving antenna is V polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
- 3. Compare the results derived from above two steps. So, the axis of maximum emission from EUT was determined and the configuration was used to perform the final measurement.

Final Radiated Emission Measurement

- 1. Setup the configuration according to figure 1. Turn on EUT and make sure that it is in normal function.
- 2. For emission frequencies measured below 1GHz, a pre-scan is performed in a shielded chamber to determine the accurate frequencies of higher emissions will be checked on an open test site. As the same purpose, for emission frequencies measured above 1GHz, a pre-scan also be performed with a 1 meter measuring distance before final test.
- 3. For emission frequencies measured below and above 1GHz, set the spectrum analyzer on a 100kHz and 1MHz resolution bandwidth respectively for each frequency measured in step 2.
- 4. The search antenna is to be raised and lowered over a range from 1 to 4 meters in horizontally polarized orientation. Position the highness when the highest value is indicated on spectrum analyzer, then change the orientation of EUT on test table over a range from 0° to 360° with a speed as slow as possible, and keep the azimuth that highest emission is indicated on the spectrum analyzer. Vary the antenna position again and record the highest value as a final reading.
- 5. Repeat step 4 until all frequencies need to be measured was complete.
- 6. Repeat step 5 with search antenna in vertical polarized orientations.

During the radiated emission test, the Spectrum Analyzer was set with the following configurations:

| Frequency Band (MHz) | Function | Resolution bandwidth | Video Bandwidth |
|----------------------|----------|----------------------|-----------------|
| 30 to 1000 | Peak | 100kHz | 100kHz |
| Above 1000 | Peak | 1MHz | 1MHz |
| Above 1000 | Average | 1MHz | 10Hz |

Sample Calculation Example

The field strength is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain (if any) from the measured reading. For the limit is employed average value, therefore the peak value can be transferred to average value by subtracting the duty factor. The basic equation with a sample calculation is as follows:

Peak = Reading + Corrected Factor

where

Corr. Factor = Antenna Factor + Cable Factor - Amplifier Gain (if any)
And the average value is

Average = Peak Value + Duty Factor or Set RBW = 1MHz, VBW = 10Hz.

Note:

If the measured frequencies are fall in the restricted frequency band, the limit employed must be quasi peak value when frequencies are below or equal to 1GHz. And the measuring instrument is set to quasi peak detector function.



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II: TII70-XX-N
Model See P5
FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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EUT AND TEST SETUP PHOTOGRAPHS Annex B.

Annex B.i. **Photograph 1: EUT External Photo**



EUT - Front View



EUT - Rear View

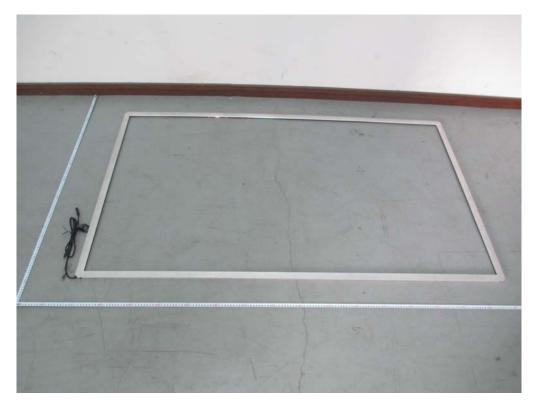
SIEMIC, INC.

Title: EMC Test Report for IR Multi-Point TOUCH FRAME
Model: TII70-XX-N
Serial Model See P5
To: FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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EUT – Top View



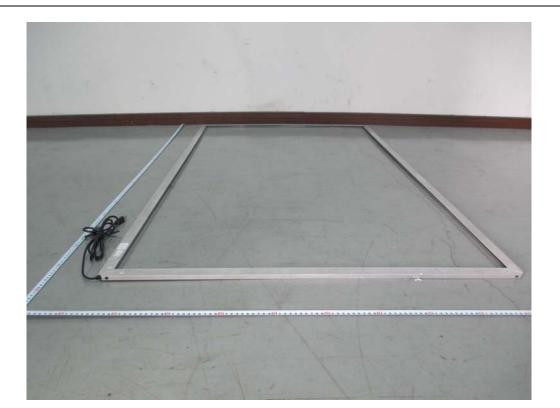
 $EUT-Bottom\ View$

Title: Model: Serial Model To:

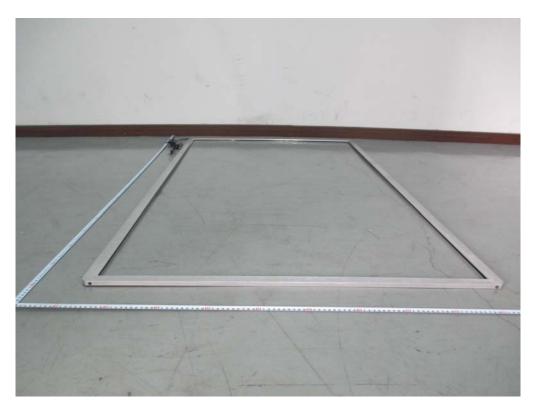
SIEMIC, INC.

EMC Test Report for IR Multi-Point TOUCH FRAME
H: TII70-XX-N
I Model See P5
FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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EUT – Left View



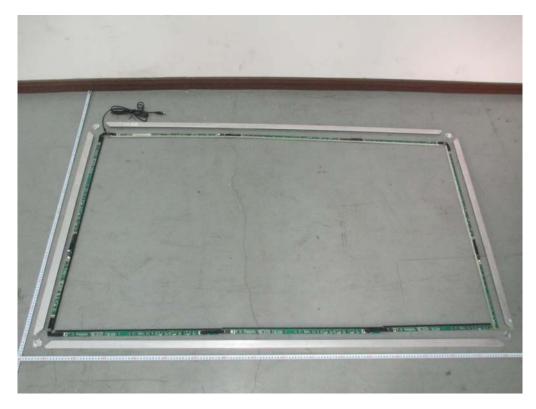
EUT – Right View



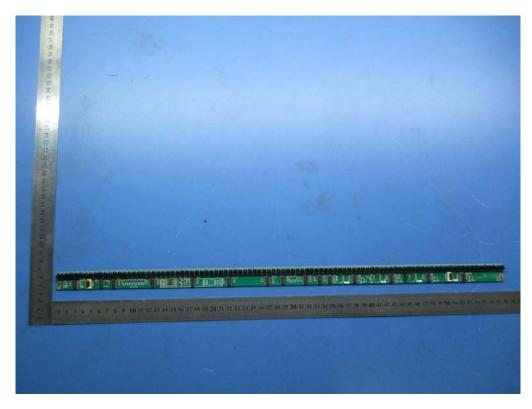
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Photograph 2: EUT Internal Photo Annex B.ii.



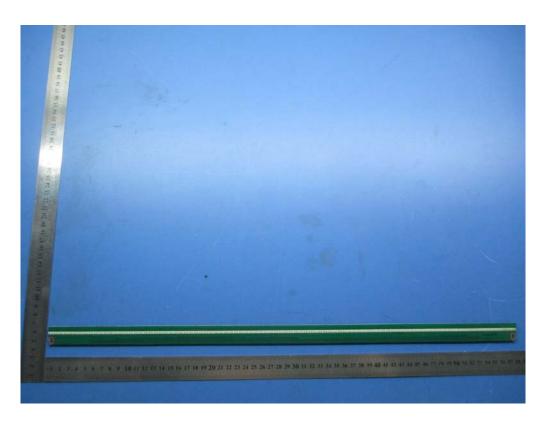
EUT – Uncover Front View



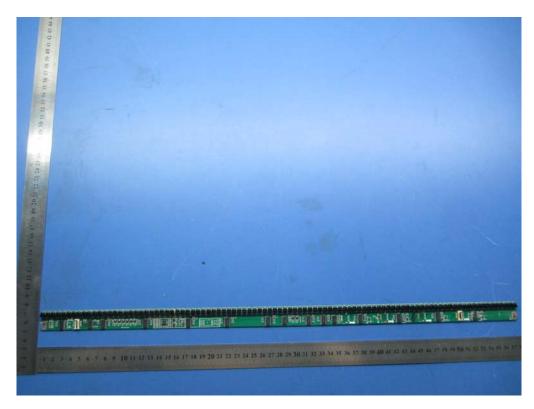
EUT PCB Board1 - Front View



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EUT PCB Board1 - Rear View



EUT PCB Board 2 - Front View

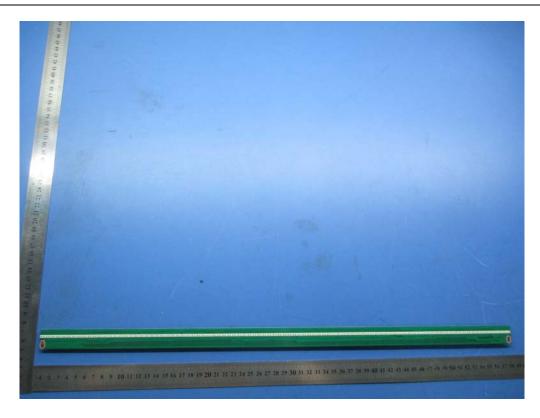


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EMC Test Report for IR Multi-Point TOUCH FRAME
1: TII70-XX-N

See P5
FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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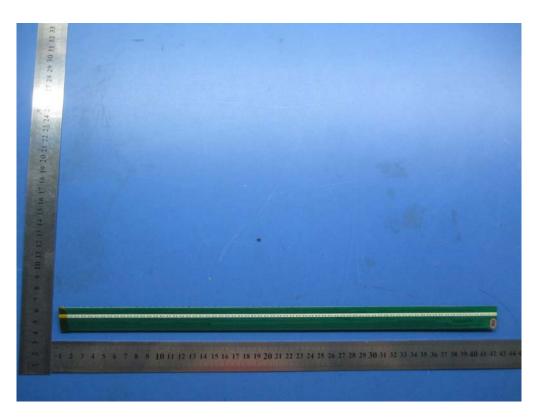
EUT PCB Board 2 - Rear View



EUT PCB Board 3 - Front View



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EUT PCB Board 3 - Rear View



EUT PCB Board 4 - Front View



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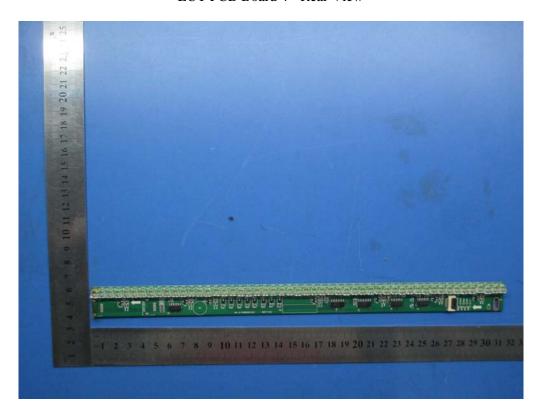
EMC Test Report for IR Multi-Point TOUCH FRAME
TII70-XX-N
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FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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10 17 12 13 14 15 16 17 18 19 20 21 22 21 24 25 26 27 28 29 30 31 32 33 34 35 36 37 38 39 40 41 42 45 44 45

EUT PCB Board 4 - Rear View



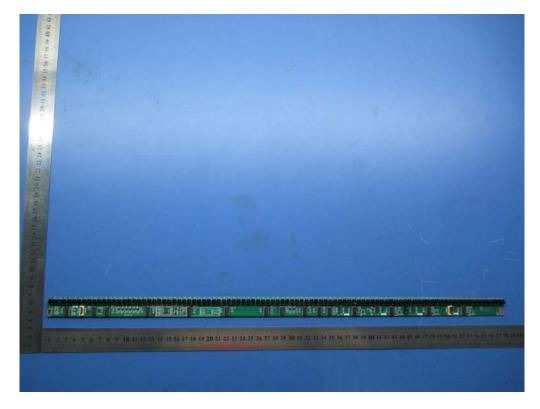
EUT PCB Board 5 - Front View



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EUT PCB Board 5 - Rear View



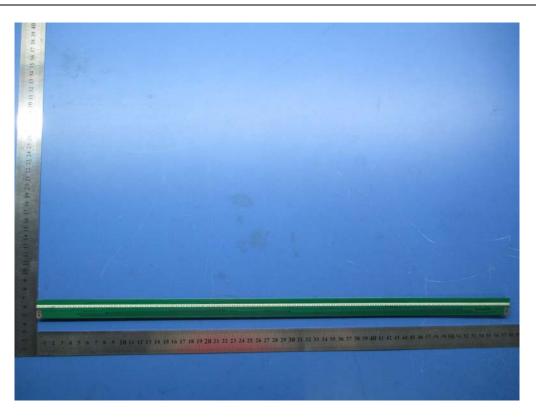
EUT PCB Board 6 - Front View



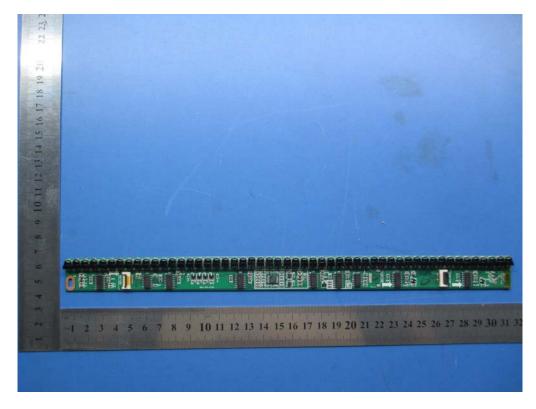
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TII70-XX-N
Model See P5
FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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EUT PCB Board 6 - Rear View



EUT PCB Board 7 - Front View

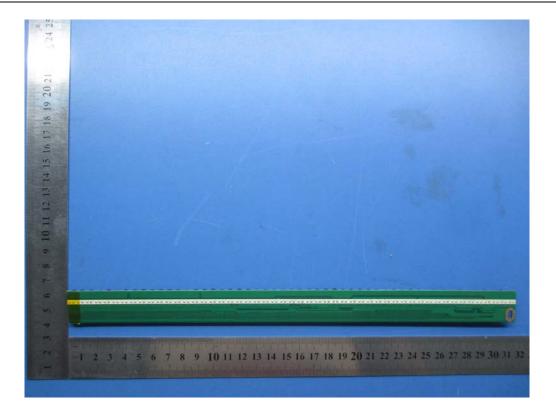


SIEMIC, INC.

EMC Test Report for IR Multi-Point TOUCH FRAME
1: TII70-XX-N

See P5
FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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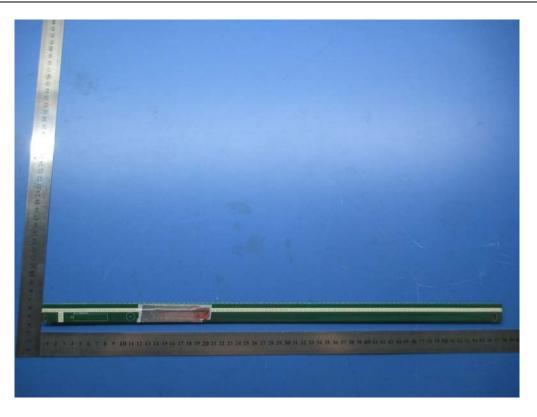
EUT PCB Board 7 - Rear View



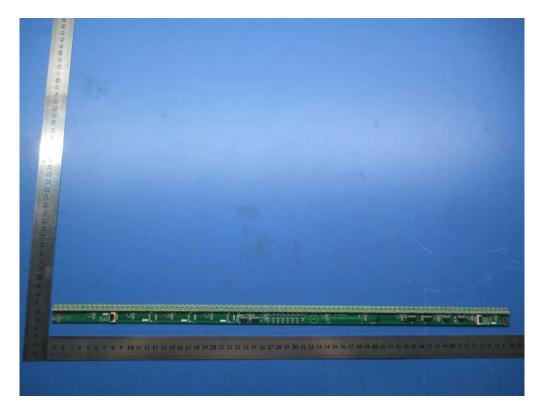
EUT PCB Board 8- Front View



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EUT PCB Board 8 - Rear View



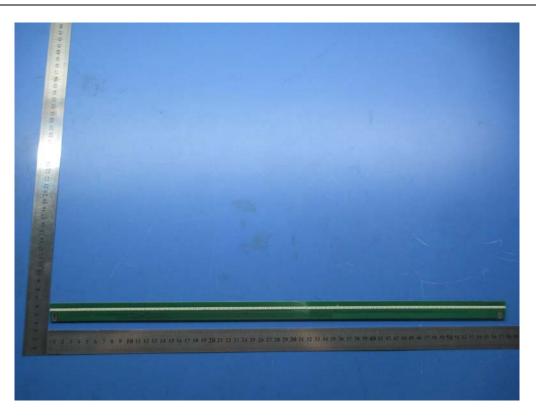
EUT PCB Board 9- Front View



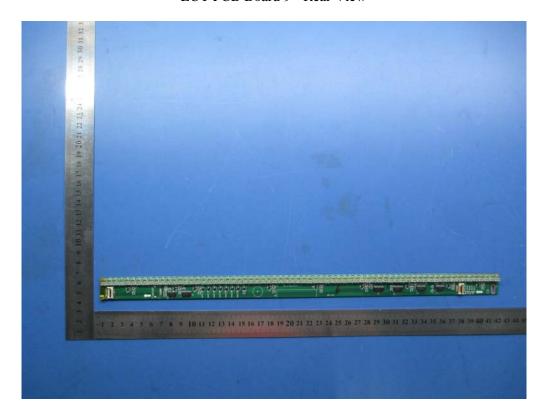
SIEMIC, INC.

EMC Test Report for IR Multi-Point TOUCH FRAME
TII70-XX-N
Model See P5
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EUT PCB Board 9 - Rear View



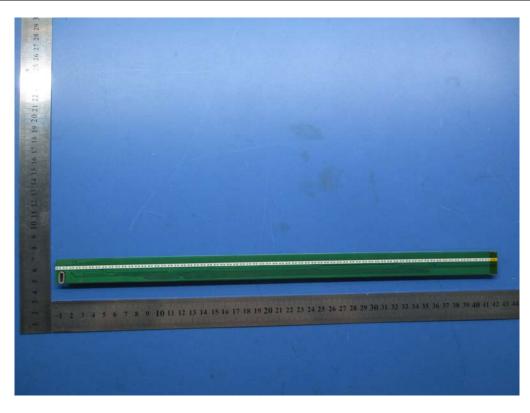
EUT PCB Board 10- Front View



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ENIC Test Report for IR Multi-Point TOUCH FRAME
TII70-XX-N
I Model See P5
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EUT PCB Board 10 - Rear View



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I: TII70-XX-N

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Annex B.iii. **Photograph 3: Test Setup Photo**



Conducted Emissions Test Setup Front View



Conducted Emissions Test Setup Side View

Title: Model: Serial Model

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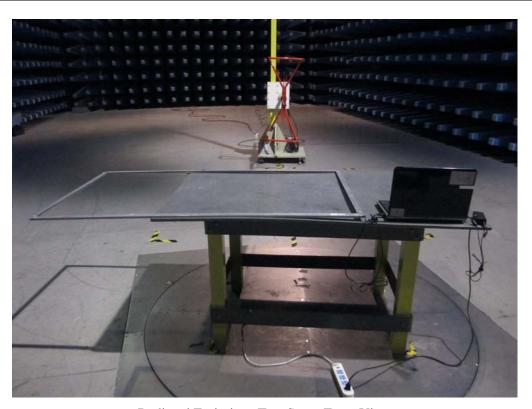
EMC Test Report for IR Multi-Point TOUCH FRAME

I: TII70-XX-N

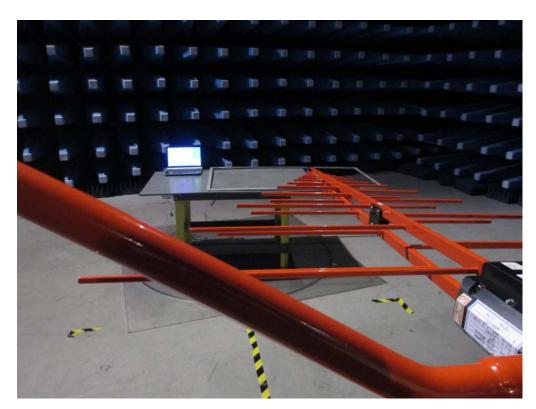
Model See P5

FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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Radiated Emissions Test Setup Front View



Radiated Emissions Test Setup Rear View



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Annex C. TEST SETUP AND SUPPORTING EQUIPMENT

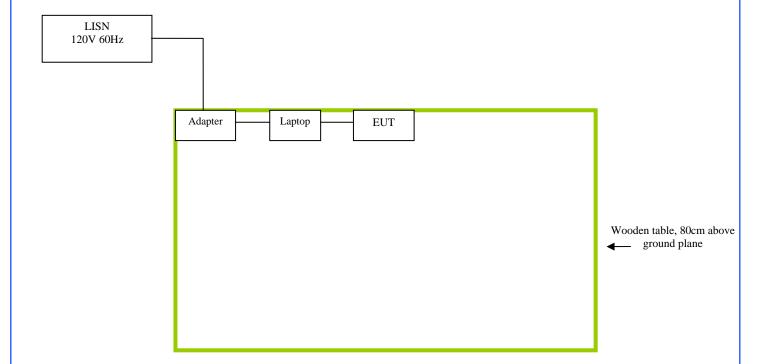
EUT TEST CONDITIONS

Annex C. i. SUPPORTING EQUIPMENT DESCRIPTION

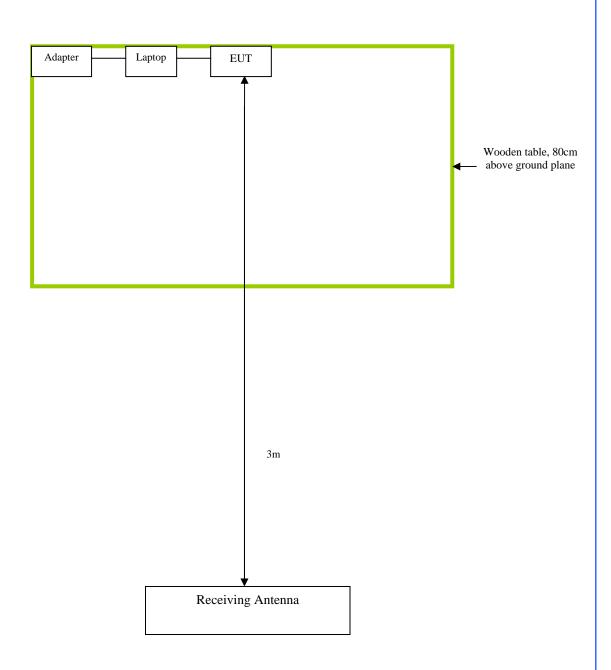
The following is a description of supporting equipment and details of cables used with the EUT.

| Equipment Description (Including Brand Name) | Model & Serial Number | Cable Description (List Length, Type & Purpose) |
|--|------------------------------------|--|
| Gateway Laptop | MS2288 & LXWHF02013951C3CA92200 | N/A |

Block Configuration Diagram for Conducted Emissions



Block Configuration Diagram for Radiated Emissions





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Annex C.ii. **EUT OPERATING CONDITIONS**

The following is the description of how the EUT is exercised during testing.

| Test | Description Of Operation |
|--------------------------|--------------------------|
| Emissions Testing | Normal Working |



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Annex D. USER MANUAL / BLOCK DIAGRAM / SCHEMATICS / PART LIST

Please see attachment

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Annex E. DECLARATION OF SIMILARITY

IRMTOUCH INC.

Statement

We

IRMTOUCH INC.

Of

Building 5, No 445 Humin Road, Minhang, Shanghai, China

hereby state that

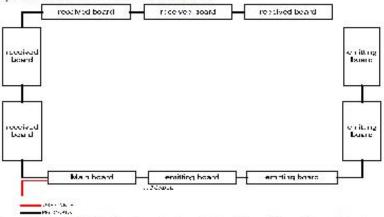
Product: IR Multi-Point TOUCH FRAME

Model Number: TII70-XX-N, TII65-XX-N, TII60-XX-N, TII55-XX-N, TII52-XX-N,

TII47-XX-N, TII46-XX-N, TII42-XX-N, TII37-XX-N, TII32-XX-N

All models are belongs to one product series.

The below figure is the assembly drawing of the touch frame. One touch frame is composed of mainly two kinds of PCBA, One is IR-light emitting board, and another is received board. The main board is one special IR-light emitting board, and it is the core of the touch frame.



The two kinds of PCBA is standard modular. The different models have the same constructions, circuit diagram. The difference of these models is its size, is mainly reflected in the number of received board and emitting board in different.

When we test, the tested model is the maximal size, and work under peak load

The character "XX" is defined as the touch point number. The touch point number is related to the algorithm of software, and is not related to the circuit constructions.

SIEMIC, INC.

EMC Test Report for IR Multi-Point TOUCH FRAME

I: TII70-XX-N Title: EMC Test Report.

Model: TII70-XX-N
Serial Model See P5
To: FCC Part 15 Subpart B Class B: 2013, ANSI C63.4:2009

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The last character "N" is defined as the software driver type. The character "N" means plug and play.

Sincerely,

Signature

E-mail: Liwy@irmtouch.com Phone: 086-21-33885751 Fax: 086-21-33885752

Address: Building 5, No 445 Humin Road, Minhang, Shanghai, China